

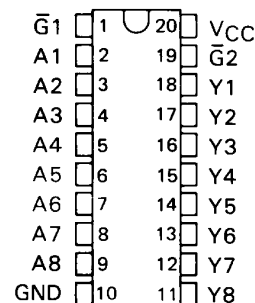
SN54ALS2540, SN54ALS2541, SN74ALS2540, SN74ALS2541 OCTAL LINE DRIVERS/MOS DRIVERS WITH 3-STATE OUTPUTS

JUNE 1984—REVISED MAY 1986

- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- P-N-P Inputs Reduce DC Loading
- Outputs Have 25- Ω Series Resistor, So No External Resistors are Required
- Package Options Include Plastic "Small Outline" Packages, Plastic and Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

SN54ALS2540, SN54ALS2541 . . . J PACKAGE
SN74ALS2540, SN74ALS2541 . . . DW OR N PACKAGE

(TOP VIEW)



description

These octal buffers and line drivers are designed to drive capacitive input characteristics of MOS devices and have the performance of the popular SN54ALS240A/SN74ALS240A series. At the same time, they offer a pinout with inputs and outputs on opposite sides of the package. This arrangement greatly enhances printed-circuit-board layout.

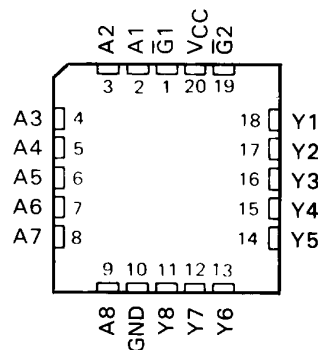
The three-state control gate is a 2-input AND with active-low inputs such that if either $\bar{G}1$ or $\bar{G}2$ is high, all eight outputs are in the high-impedance state.

The 'ALS2540 offers inverting data and the 'ALS2541 offers true data at the outputs.

The SN54ALS' is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS' is characterized for operation from 0°C to 70°C .

SN54ALS2540, SN54ALS2541 . . . FK PACKAGE

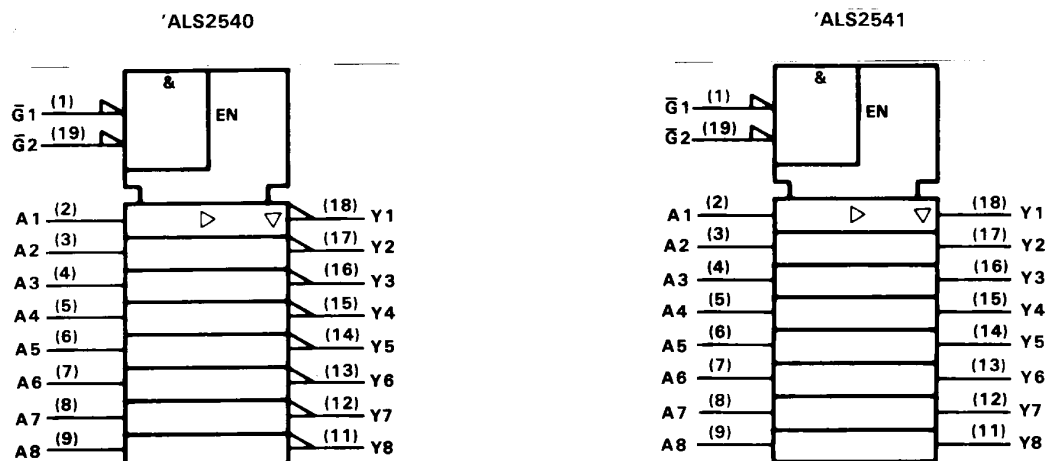
(TOP VIEW)



SN54ALS2540, SN54ALS2541, SN74ALS2540, SN74ALS2541 **OCTAL LINE DRIVERS/MOS DRIVERS WITH 3-STATE OUTPUTS**

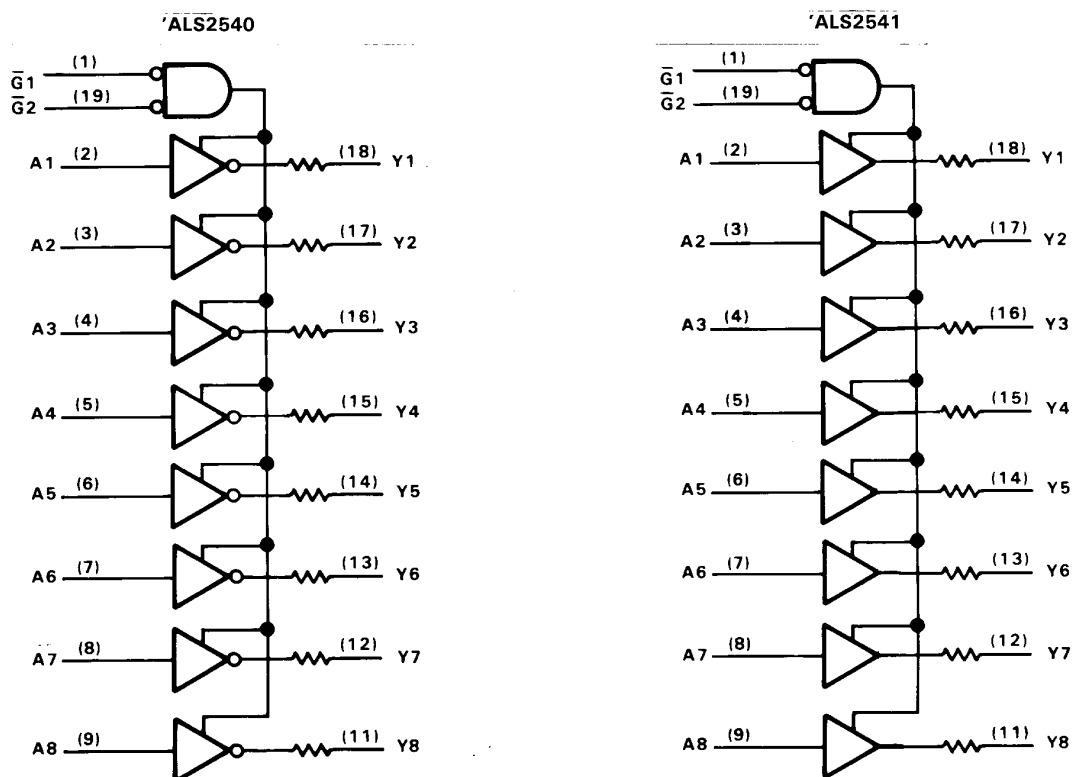
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logic symbols[†]



[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagrams (positive logic)



All output resistors are 25 Ω.

SN54ALS2540, SN54ALS2541, SN74ALS2540, SN74ALS2541 OCTAL LINE DRIVERS/MOS DRIVERS WITH 3-STATE OUTPUTS

JUNE 1984—REVISED MAY 1986

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC}	7 V
Input voltage	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range: SN54ALS2540, SN54ALS2541	–55°C to 125°C
SN74ALS2540, SN74ALS2541	0°C to 70°C
Storage temperature range	–65°C to 150°C

recommended operating conditions

		SN54ALS2540 SN54ALS2541			SN74ALS2540 SN74ALS2541			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current			–0.4			–0.4	mA
I_{OL}	Low-level output current			12			12	mA
T_A	Operating free-air temperature	–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS2540		SN74ALS2540		UNIT		
				SN54ALS2541		SN74ALS2541				
				MIN	TYP†	MAX	MIN	TYP†	MAX	
V _{IK}		V _{CC} = 4.5 V, I _I = -18 mA				-1.2			-1.2	V
V _{OH}		V _{CC} = 4.5 V to 5.5 V, I _{OH} = -0.4 mA		V _{CC} -2		V _{CC} -2				V
V _{OL}		V _{CC} = 4.5 V, I _{OL} = 1 mA		0.15		0.5	0.15		0.5	V
		V _{CC} = 4.5 V, I _{OL} = 12 mA		0.35		0.8	0.35		0.8	
I _{OZH}		V _{CC} = 5.5 V, V _O = 2.7 V				20			20	μA
I _{OZL}		V _{CC} = 5.5 V, V _O = 0.4 V				-20			-20	μA
I _{OH}		V _{CC} = 4.5 V, V _O = 2 V		-15			-15			mA
I _{OL}		V _{CC} = 4.5 V, V _O = 2 V		30			30			mA
I _I		V _{CC} = 5.5 V, V _I = 7 V				0.1			0.1	mA
I _{IH}		V _{CC} = 5.5 V, V _I = 2.7 V				20			20	μA
I _{IL}		V _{CC} = 5.5 V, V _I = 0.4 V				-0.1			-0.1	mA
I _{O‡}		V _{CC} = 5.5 V, V _O = 2.25 V		-15		-70	-15		-70	mA
I _{CC}	'ALS2540	V _{CC} = 5.5 V	Outputs high	5		10	5		10	mA
			Outputs low	13		22	13		22	
			Outputs disabled	11		19	11		19	
	'ALS2541	V _{CC} = 5.5 V	Outputs high	6		14	6		14	mA
			Outputs low	15		25	15		25	
			Outputs disabled	13.5		22	13.5		22	

† All typical values are at $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$.

‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

SN54ALS2540, SN54ALS2541, SN74ALS2540, SN74ALS2541 **OCTAL LINE DRIVERS/MOS DRIVERS WITH 3-STATE OUTPUTS**

JUNE 1984—REVISED MAY 1986

'ALS2540 switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5\text{ V},$ $C_L = 50\text{ pF},$ $R_1 = 500\ \Omega,$ $R_2 = 500\ \Omega,$ $T_A = 25^\circ\text{C}$	$V_{CC} = 4.5\text{ V to }5.5\text{ V},$ $C_L = 50\text{ pF},$ $R_1 = 500\ \Omega,$ $R_2 = 500\ \Omega,$ $T_A = \text{MIN to MAX}$				UNIT
			'ALS2540	SN54ALS2540		SN74ALS2540		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	7.5	2	14	2	12	ns
t_{PHL}			5.6	2	13	2	11	
t_{PZH}	\overline{G}	Y	9	5	18	5	15	ns
t_{PZL}			12.6	8	24	8	20	
t_{PHZ}	\overline{G}	Y	4	1	12	1	10	ns
t_{PLZ}			7	2	14	2	12	

'ALS2541 switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5\text{ V},$ $C_L = 50\text{ pF},$ $R_1 = 500\ \Omega,$ $R_2 = 500\ \Omega,$ $T_A = 25^\circ\text{C}$	$V_{CC} = 4.5\text{ V to }5.5\text{ V},$ $C_L = 50\text{ pF},$ $R_1 = 500\ \Omega,$ $R_2 = 500\ \Omega,$ $T_A = \text{MIN to MAX}$				UNIT
			ALS2541	SN54ALS2541		SN74ALS2541		
			TYP	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	8.7	2	17	2	15	ns
t_{PHL}			7	2	14	2	12	
t_{PZH}	\overline{G}	Y	9	5	18	5	15	ns
t_{PZL}			12.6	8	24	8	20	
t_{PHZ}	\overline{G}	Y	4	1	12	1	10	ns
t_{PLZ}			7	2	14	2	12	

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.

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